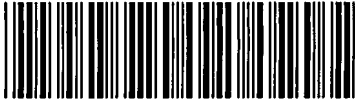


Search Notes

Application/Control No.

10/759,325

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under
Reexamination

PAFF ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	62	6/11/2007	CHUN-KUAN Lee

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Inventor search utilizing eDan and EAST	6/11/2007	CHUN-KUAN Lee